

31DF4-31DF6

3.0 AMP. Super Fast Rectifiers



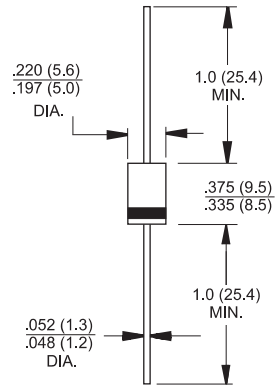
Features

- ◇ High efficiency, Low VF
- ◇ High current capability
- ◇ High reliability
- ◇ High surge current capability
- ◇ Low power loss.

Mechanical Data

- ◇ Cases: Molded plastic
- ◇ Epoxy: UL 94V-0 rate flame retardant
- ◇ Polarity: Color band denotes cathode end
- ◇ High temperature soldering guaranteed:
260°C/10 seconds/.375", (9.5mm) lead
lengths at 5 lbs., (2.3kg) tension
- ◇ Weight: 1.2 grams

DO-201AD



Dimensions in inches and (millimeters)

Maximum Ratings and Electrical Characteristics

Rating at 25°C ambient temperature unless otherwise specified.

Single phase, half wave, 60 Hz, resistive or inductive load.

For capacitive load, derate current by 20%

Type Number	Symbol	31DF4	31DF6	Units
Maximum Recurrent Peak Reverse Voltage	V_{RRM}	400	600	V
Maximum RMS Voltage	V_{RMS}	280	420	V
Maximum DC Blocking Voltage	V_{DC}	400	600	V
Maximum Average Forward Rectified Current .375 (9.5mm) Lead Length @ $T_A = 29^\circ\text{C}$ (Note 1) @ $T_L = 109^\circ\text{C}$	$I_{(AV)}$	1.2 3.0		A
Peak Forward Surge Current, 8.3 ms Single Half Sine-wave Superimposed on Rated Load (JEDEC method)	I_{FSM}	45		A
Maximum Instantaneous Forward Voltage @ 3.0A	V_F	1.7		V
Maximum DC Reverse Current @ $T_A = 25^\circ\text{C}$ at Rated DC Blocking Voltage @ $T_A = 125^\circ\text{C}$	I_R	20 100		uA
Maximum Reverse Recovery Time (Note 3)	T_{rr}	35		nS
Typical Thermal Resistance (Note 2)	$R_{\theta JA}$	80		°C/W
Operating Temperature Range	T_J	-40 to +150		°C
Storage Temperature Range	T_{STG}	-40 to +150		°C

- Notes:
1. Without Fin or P.C.Board..
 2. Thermal Resistance from Junction to Ambient .375" (9.5mm) Lead Length.
 3. Reverse recovery Test Condition: $T_a = 25^\circ\text{C}$, $I_{FM} = 3A$, $di/dt = 50A / \mu s$.

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RATINGS AND CHARACTERISTIC CURVES (31DF4 THRU 31DF6)

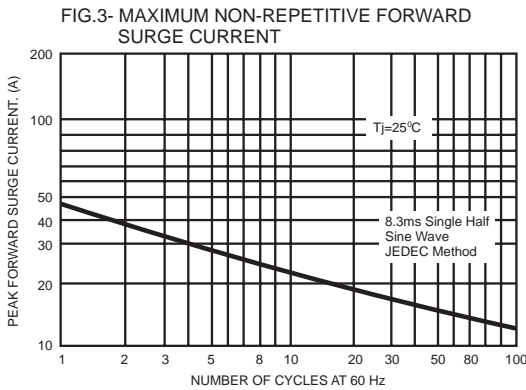
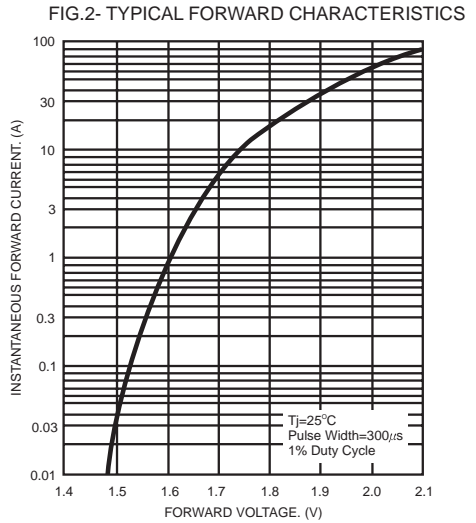
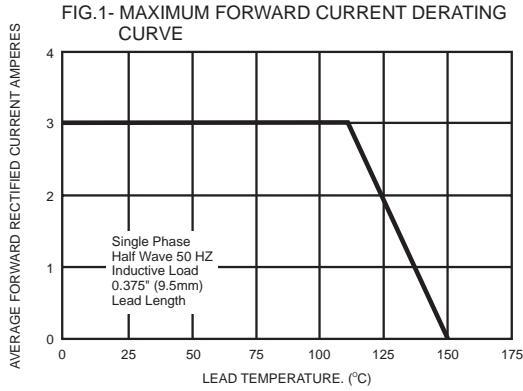


FIG.4- TYPICAL REVERSE CHARACTERISTICS

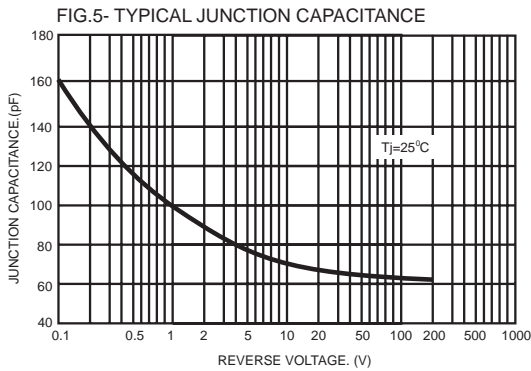
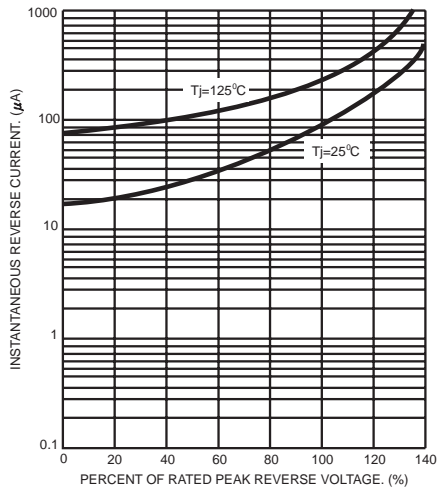


FIG.6- REVERSE RECOVERY TIME CHARACTERISTIC AND TEST CIRCUIT DIAGRAM

